



PATENT
Atty Docket KLAC0003

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of
DIETER MUELLER ET AL.
Title: COPPER CMP FLATNESS MONITOR
USING GRAZING INCIDENCE INTERFEROMETRY
Serial No.: 09/693,614
Filed: October 20, 2000

Group Art Unit: 2877
Examiner: Hwa S. Lee

TRANSMITTAL LETTER/CERTIFICATE OF MAILING

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Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

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I hereby certify that the following:


- ☒ Request for Continued Examination Transmittal (Form PTO/SB/30)
- ☒ Check in the amount of \$806 as a filing fee (\$770 filing plus \$36 excess claims)
- ☒ Amendment Accompanying Request for Continued Examination (RCE)
- ☒ Claim Fee Determination Record
- ☒ Information Disclosure Statement, Form PTO-1449, and two references
- ☒ Return postcard

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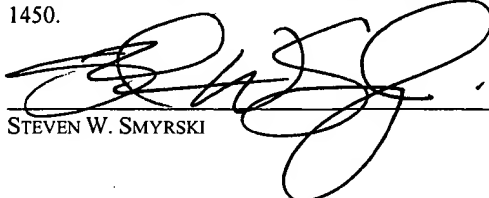

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**AMENDMENT ACCOMPANYING REQUEST FOR CONTINUED
EXAMINATION (RCE)**

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Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

In response to the Office Action dated October 28, 2003, please enter the following amendments and consider the following remarks in connection with the above-identified patent application.